74HC4020; 74HCT4020 14-stage binary ripple counter Rev. 6 – 3 February 2016

General description 1.

The 74HT4020; 74HCT4020 is a 14-stage binary ripple counter with a clock input (CP), an overriding asynchronous master reset input (MR) and 12 buffered parallel outputs (Q0, and Q3 to Q13). The counter advances on the HIGH-to-LOW transition of CP. A HIGH on MR clears all counter stages and forces all outputs LOW, independent of the state of CP. Each counter stage is a static toggle flip-flop. This device features reduced input threshold levels to allow interfacing to TTL logic levels. Inputs also include clamp diodes, this enables the use of current limiting resistors to interface inputs to voltages in excess of V_{CC}.

2. **Features and benefits**

- Wide supply voltage range from 2.0 V to 6.0 V
- Input levels:
 - For 74HC4020: CMOS level
 - For 74HCT4020: TTL level
- Multiple package options
- Complies with JEDEC standard no. 7A
- Specified from –40 °C to +85 °C and from –40 °C to +125 °C

Applications 3.

- Frequency dividing circuits
- Time delay circuits
- Control counters

Ordering information 4.

Table 1. **Ordering information**

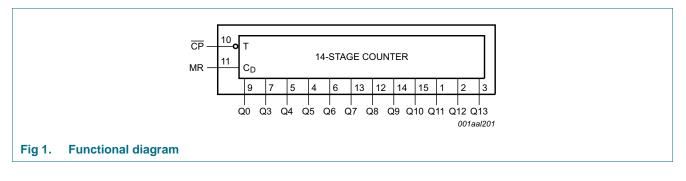
Type number	Package								
	Temperature range	Name	Description	Version					
74HC4020D	–40 °C to +125 °C	SO16	plastic small outline package; 16 leads;	SOT109-1					
74HCT4020D			body width 3.9 mm						
74HC4020DB	–40 °C to +125 °C	SSOP16	plastic shrink small outline package; 16 leads; body	SOT338-1					
74HCT4020DB			width 5.3 mm						

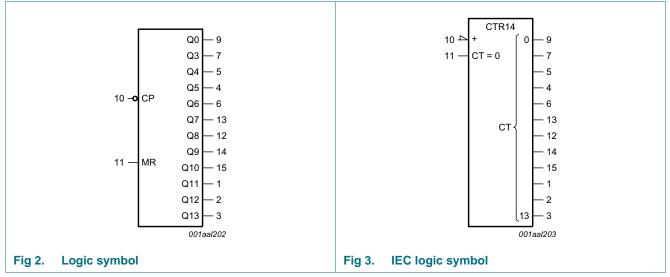


Type number Package Temperature range Name Description Version 74HC4020PW –40 °C to +125 °C TSSOP16 plastic thin shrink small outline package; 16 leads; SOT403-1 body width 4.4 mm 74HCT4020PW 74HC4020BQ –40 °C to +125 °C DHVQFN16 plastic dual in-line compatible thermal enhanced SOT763-1 very thin quad flat package; no leads; 16 terminals; 74HCT4020BQ body $2.5 \times 3.5 \times 0.85$ mm

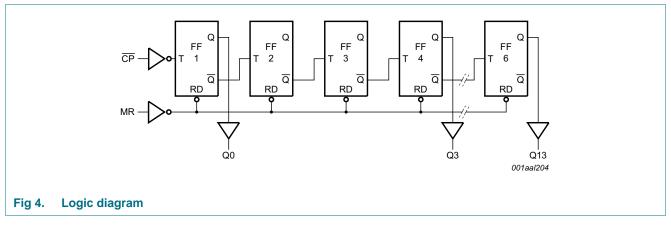
Table 1. Ordering information ...continued

5. Functional diagram

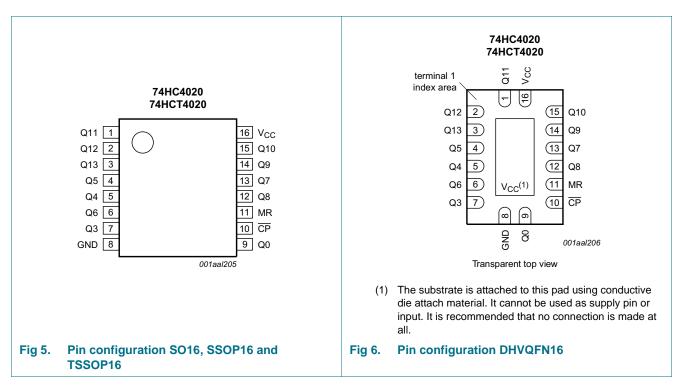




14-stage binary ripple counter



6. Pinning information



6.1 Pinning

6.2 Pin description

Symbol	Pin	Description
Q0, Q3 to Q13	9, 7, 5, 4, 6, 13, 12, 14, 15, 1, 2, 3	output
GND	8	ground (0 V)
CP	10	clock input (HIGH-to-LOW, edge-triggered)
MR	11	master reset input (active HIGH)
V _{CC}	16	positive supply voltage

⁷⁴HC_HCT4020

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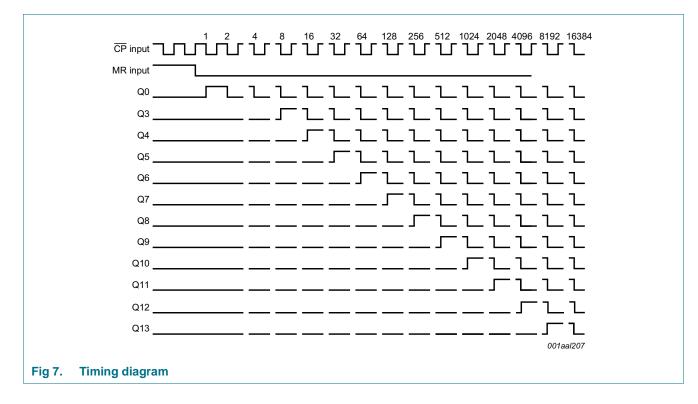
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7. Functional description

Table 3.	Table 3. Function table							
Input		Output						
СР		MR	Q0, Q3 to Q13					
↑		L	no change					
\downarrow		L	count					
Х		Н	L					

[1] H = HIGH voltage level; L = LOW voltage level; X = don't care; \uparrow = LOW-to-HIGH clock transition; \downarrow = HIGH-to-LOW clock transition.

7.1 Timing diagram



8. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{CC}	supply voltage		-0.5	+7	V
I _{IK}	input clamping current	$V_{I} < -0.5$ V or $V_{I} > V_{CC}$ + 0.5 V	-	±20	mA
I _{OK}	output clamping current	$V_{I} < -0.5$ V or $V_{I} > V_{CC}$ + 0.5 V	-	±20	mA
lo	output current	$-0.5 \text{ V} < \text{V}_{\text{O}} < \text{V}_{\text{CC}} + 0.5 \text{ V}$	-	±25	mA
I _{CC}	supply current		-	±50	mA
I _{GND}	ground current		-	±50	mA
T _{stg}	storage temperature		-65	+150	°C
P _{tot}	total power dissipation	$T_{amb} = -40 \text{ °C to } +125 \text{ °C}$	[1]		
		SO16, SSOP16, TSSOP16 and DHVQFN16 packages	-	500	mW

For SO16 package: Ptot derates linearly with 8 mW/K above 70 °C.
 For SSOP16 and TSSOP16 packages: Ptot derates linearly with 5.5 mW/K above 60 °C.
 For DHVQFN16 package: Ptot derates linearly with 4.5 mW/K above 60 °C.

9. Recommended operating conditions

Table 5. Recommended operating conditions

Symbol	Parameter	Conditions	7	4HC402	20	74	HCT40	20	Unit
			Min	Тур	Max	Min	Тур	Max	
V _{CC}	supply voltage		2.0	5.0	6.0	4.5	5.0	5.5	V
VI	input voltage		0	-	V _{CC}	0	-	V _{CC}	V
Vo	output voltage		0	-	V _{CC}	0	-	V _{CC}	V
$\Delta t / \Delta V$	input transition rise and fall rate	except for Schmitt trigger inputs							
		V _{CC} = 2.0 V	-	-	625	-	-	-	ns/V
		V _{CC} = 4.5 V	-	1.67	139	-	1.67	139	ns/V
		V _{CC} = 6.0 V	-	-	83	-	-	-	ns/V
T _{amb}	ambient temperature		-40	+25	+125	-40	+25	+125	°C

10. Static characteristics

Table 6. Static characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		25 °C		–40 °C t	o +85 °C	-40 °C te	o +125 °C	Unit
			Min	Тур	Max	Min	Max	Min	Max	
74HC40	20									1
V _{IH}	HIGH-level	V _{CC} = 2.0 V	1.5	1.2	-	1.5	-	1.5	-	V
	input voltage	V _{CC} = 4.5 V	3.15	2.4	-	3.15	-	3.15	-	V
		V _{CC} = 6.0 V	4.2	3.2	-	4.2	-	4.2	-	V
V _{IL}	LOW-level	V _{CC} = 2.0 V	-	0.8	0.5	-	0.5	-	0.5	V
	input voltage	$V_{CC} = 4.5 V$	-	2.1	1.35	-	1.35	-	1.35	V
		V _{CC} = 6.0 V	-	2.8	1.8	-	1.8	-	1.8	V
V _{OH}	HIGH-level	$V_{I} = V_{IH} \text{ or } V_{IL}$								
	output voltage	$I_{O} = -20 \ \mu A; \ V_{CC} = 2.0 \ V$	1.9	2.0	-	1.9	-	1.9	-	V
		$I_{O} = -20 \ \mu A; \ V_{CC} = 4.5 \ V$	4.4	4.5	-	4.4	-	4.4	-	V
		$I_{O} = -20 \ \mu A; \ V_{CC} = 6.0 \ V$	5.9	6.0	-	5.9	-	5.9	-	V
		I_{O} = -4.0 mA; V_{CC} = 4.5 V	3.98	4.32	-	3.84	-	3.7	-	V
		$I_{O} = -5.2 \text{ mA}; V_{CC} = 6.0 \text{ V}$	5.48	5.81	-	5.34	-	5.2	-	V
V _{OL} LOW-level	$V_{I} = V_{IH} \text{ or } V_{IL}$									
	output voltage	$I_0 = 20 \ \mu A; \ V_{CC} = 2.0 \ V$	-	0	0.1	-	0.1	-	0.1	V
		$I_{O} = 20 \ \mu A; \ V_{CC} = 4.5 \ V$	-	0	0.1	-	0.1	-	0.1	V
		$I_{O} = 20 \ \mu A; \ V_{CC} = 6.0 \ V$	-	0	0.1	-	0.1	-	0.1	V
		I_{O} = 4.0 mA; V_{CC} = 4.5 V	-	0.15	0.26	-	0.33	-	0.4	V
		$I_{O} = 5.2 \text{ mA}; V_{CC} = 6.0 \text{ V}$	-	0.16	0.26	-	0.33	-	0.4	V
I	input leakage current	$V_I = V_{CC}$ or GND; $V_{CC} = 6.0 V$	-	-	±0.1	-	±1	-	±1	μA
I _{CC}	supply current	$V_I = V_{CC}$ or GND; $I_O = 0$ A; $V_{CC} = 6.0$ V	-	-	8.0	-	80	-	160	μA
CI	input capacitance		-	3.5	-	-	-	-	-	pF
74HCT4	020	1								
V _{IH}	HIGH-level input voltage	V_{CC} = 4.5 V to 5.5 V	2.0	1.6	-	2.0	-	2.0	-	V
V _{IL}	LOW-level input voltage	V_{CC} = 4.5 V to 5.5 V	-	1.2	0.8	-	0.8	-	0.8	V
V _{он}	HIGH-level	$V_{I} = V_{IH} \text{ or } V_{IL}; V_{CC} = 4.5 \text{ V}$								
	output voltage	I _O = -20 μA	4.4	4.5	-	4.4	-	4.4	-	V
		I _O = -4.0 mA	3.98	4.32	-	3.84	-	3.7	-	V
V _{OL}	LOW-level	$V_{I} = V_{IH} \text{ or } V_{IL}; V_{CC} = 4.5 \text{ V}$								
	output voltage	$I_{O} = 20 \ \mu A; V_{CC} = 4.5 \ V$	-	0	0.1	-	0.1	-	0.1	V
		I_{O} = 4.0 mA; V_{CC} = 4.5 V	-	0.15	0.26	-	0.33	-	0.4	V
lı	input leakage current	$V_I = V_{CC}$ or GND; $V_{CC} = 5.5 V$	-	-	±0.1	-	±1	-	±1	μA

Table 6. Static characteristics ...continued

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions		25 °C -		–40 °C t	o +85 °C	–40 °C to	Unit	
			Min	Тур	Max	Min	Max	Min	Max	
I _{CC}	supply current	$\label{eq:VI} \begin{array}{l} V_{I} = V_{CC} \text{ or } GND; \ I_{O} = 0 \ A; \\ V_{CC} = 5.5 \ V \end{array}$	-	-	8.0	-	80	-	160	μA
Δl _{CC}	additional supply current	$\label{eq:VI} \begin{array}{l} V_I = V_{CC} - 2.1 \ \text{V;} \ I_O = 0 \ \text{A;} \\ \text{other inputs at } V_{CC} \ \text{or GND;} \\ V_{CC} = 4.5 \ \text{V to } 5.5 \ \text{V} \end{array}$								
		pin MR	-	110	396	-	495	-	539	μA
		pin CP	-	85	306	-	383	-	417	μA
CI	input capacitance		-	3.5	-	-	-	-	-	pF

11. Dynamic characteristics

Table 7.Dynamic characteristics

GND (ground = 0 V); $C_L = 50 \text{ pF}$ unless otherwise specified; for test circuit, see <u>Figure 10</u>

Symbol	Parameter	Conditions		25 °C		-40 °C t	o +85 °C	–40 °C to	o +125 °C	Unit
			Min	Тур	Max	Min	Max	Min	Max	
74HC402	20			1	1			1		
t _{pd}	propagation	CP to Q0; see Figure 8 [1]								
	delay	$V_{CC} = 2.0 \text{ V}; \text{ C}_{L} = 50 \text{ pF}$	-	39	140	-	175	-	210	ns
		$V_{CC} = 4.5 \text{ V}; \text{ C}_{L} = 50 \text{ pF}$	-	14	28	-	35	-	42	ns
		V _{CC} = 5.0 V; C _L = 15 pF	-	11	-	-	-	-	-	ns
		$V_{CC} = 6.0 \text{ V}; C_{L} = 50 \text{ pF}$	-	11	24	-	30	-	36	ns
1		Qn to Qn+1; see Figure 9								
		$V_{CC} = 2.0 \text{ V}; C_{L} = 50 \text{ pF}$	-	22	75	-	95	-	110	ns
1		$V_{CC} = 4.5 \text{ V}; C_{L} = 50 \text{ pF}$	-	8	15	-	19	-	22	ns
l		$V_{CC} = 5.0 \text{ V}; \text{ C}_{L} = 15 \text{ pF}$	-	6	-	-	-	-	-	ns
1		$V_{CC} = 6.0 \text{ V}; C_{L} = 50 \text{ pF}$	-	6	13	-	16	-	19	ns
t _{PHL}	HIGH to LOW	MR to Qn; see Figure 8								
1	propagation	V _{CC} =2.0 V; C _L = 50 pF	-	55	170	-	215	-	225	ns
1	delay	$V_{CC} = 4.5 \text{ V}; C_{L} = 50 \text{ pF}$	-	20	34	-	43	-	51	ns
1		$V_{CC} = 5.0 \text{ V}; C_{L} = 15 \text{ pF}$	-	17	-	-	-	-	-	ns
1		$V_{CC} = 6.0 \text{ V}; C_{L} = 50 \text{ pF}$	-	16	29	-	37	-	43	ns
t _t	transition	Qn; see Figure 8 [2]								
	time	$V_{CC} = 2.0 \text{ V}; \text{ C}_{L} = 50 \text{ pF}$	-	19	75	-	95	-	110	ns
		$V_{CC} = 4.5 \text{ V}; \text{ C}_{L} = 50 \text{ pF}$	-	7	15	-	19	-	22	ns
		$V_{CC} = 6.0 \text{ V}; C_{L} = 50 \text{ pF}$	-	6	13	-	16	-	19	ns

14-stage binary ripple counter

Table 7. Dynamic characteristics ...continued

GND (ground = 0 V); C_L = 50 pF unless otherwise specified; for test circuit, see Figure 10

Symbol	Parameter	Conditions		25 °C	;	–40 °C t	o +85 °C	–40 °C to +125 °C		Unit
			Mir	Тур	Max	Min	Max	Min	Max	
t _W	pulse width	CP HIGH or LOW;								
		see <u>Figure 8</u>								
		$V_{CC} = 2.0 \text{ V}; \text{ C}_{L} = 50 \text{ pF}$	80	14	-	100	-	120	-	ns
		$V_{CC} = 4.5 \text{ V}; \text{ C}_{L} = 50 \text{ pF}$	16	4	-	20	-	24	-	ns
		$V_{CC} = 6.0 \text{ V}; \text{ C}_{L} = 50 \text{ pF}$	14	3	-	17	-	20	-	ns
		MR HIGH; see Figure 8								
		$V_{CC} = 2.0 \text{ V}; \text{ C}_{L} = 50 \text{ pF}$	80	17	-	100	-	120	-	ns
		V_{CC} = 4.5 V; C_{L} = 50 pF	16	6	-	20	-	24	-	ns
		$V_{CC} = 6.0 \text{ V}; \text{ C}_{L} = 50 \text{ pF}$	14	5	-	17	-	20	-	ns
t _{rec}	recovery time	MR to CP; see Figure 8								
		$V_{CC} = 2.0 \text{ V}; \text{ C}_{L} = 50 \text{ pF}$	50	6	-	65	-	75	-	ns
		$V_{CC} = 4.5 \text{ V}; \text{ C}_{L} = 50 \text{ pF}$	10	2	-	13	-	15	-	ns
		$V_{CC} = 6.0 \text{ V}; C_{L} = 50 \text{ pF}$	9	2	-	11	-	13	-	ns
f _{max}	maximum	see Figure 8								
	frequency	$V_{CC} = 2.0 \text{ V}; \text{ C}_{L} = 50 \text{ pF}$	6.0	30	-	4.8	-	4.0	-	MHz
		$V_{CC} = 4.5 \text{ V}; C_{L} = 50 \text{ pF}$	30	92	-	24	-	20	-	MHz
		$V_{CC} = 5.0 \text{ V}; \text{ C}_{L} = 15 \text{ pF}$	-	101	-	-	-	-	-	MHz
		$V_{CC} = 6.0 \text{ V}; \text{ C}_{L} = 50 \text{ pF}$	35	109	-	28	-	24	-	MHz
C _{PD}	power dissipation capacitance		[3] _	19	-	-	-	-	-	pF
74HCT4	020	1				1		1		
t _{pd}	propagation	CP to Q0; see Figure 8	<u>[1]</u>							
	delay	V _{CC} = 4.5 V; C _L = 50 pF	-	18	36	-	45	-	54	ns
		V _{CC} = 5.0 V; C _L = 15 pF	-	15	-	-	-	-	-	ns
		Qn to Qn+1; see Figure 9								
		V _{CC} = 4.5 V; C _L = 50 pF	-	8	15	-	19	-	22	ns
		$V_{CC} = 5.0 \text{ V}; \text{ C}_{L} = 15 \text{ pF}$	-	6	-	-	-	-	-	ns
t _{PHL}	HIGH to LOW	MR to Qn; see Figure 8								
	propagation	$V_{CC} = 4.5 \text{ V}; \text{ C}_{L} = 50 \text{ pF}$	-	22	45	-	56	-	68	ns
	delay	$V_{CC} = 5.0 \text{ V}; \text{ C}_{L} = 15 \text{ pF}$	-	19	-	-	-	-	-	ns
t _t	transition		[2]							
l.	time	$V_{CC} = 4.5 \text{ V}; \text{ C}_{L} = 50 \text{ pF}$	-	7	15	-	19	-	22	ns
t _W	pulse width	CP HIGH or LOW;								
		see Figure 8				05		20		80
		$V_{CC} = 4.5 \text{ V}; C_{L} = 50 \text{ pF}$	20	7	-	25	-	30	-	ns
		MR HIGH; see Figure 8				67				
		$V_{CC} = 4.5 \text{ V}; C_{L} = 50 \text{ pF}$	20	8	-	25	-	30	-	ns
t _{rec}	recovery time	MR to CP; see Figure 8								
		$V_{CC} = 4.5 \text{ V}; \text{ C}_{L} = 50 \text{ pF}$	10	2	-	13	-	15	-	ns

14-stage binary ripple counter

Table 7. Dynamic characteristics ... continued

GND (ground = 0 V); C_L = 50 pF unless otherwise specified; for test circuit, see Figure 10

Symbol	Parameter	Conditions	25 °C		–40 °C to	o +85 °C	–40 °C to	Unit		
			Min	Тур	Max	Min	Max	Min	Max	
f _{max}	f _{max} maximum frequency	see Figure 8								
		$V_{CC} = 4.5 \text{ V}; C_{L} = 50 \text{ pF}$	25	47	-	20	-	17	-	MHz
		$V_{CC} = 5.0 \text{ V}; \text{ C}_{L} = 15 \text{ pF}$	-	52	-	-	-	-	-	MHz
C _{PD}	power dissipation capacitance	[3]	-	20	-	-	-	-	-	pF

- [1] t_{pd} is the same as t_{PHL} and t_{PLH} .
- [2] t_t is the same as t_{THL} and t_{TLH} .
- [3] C_{PD} is used to determine the dynamic power dissipation (P_D in μ W).

$$\begin{split} P_{D} &= C_{PD} \times V_{CC}^{2} \times f_{i} + \Sigma \; (C_{L} \times V_{CC}^{2} \times f_{o}) \; \text{where:} \\ f_{i} &= \text{input frequency in MHz;} \end{split}$$

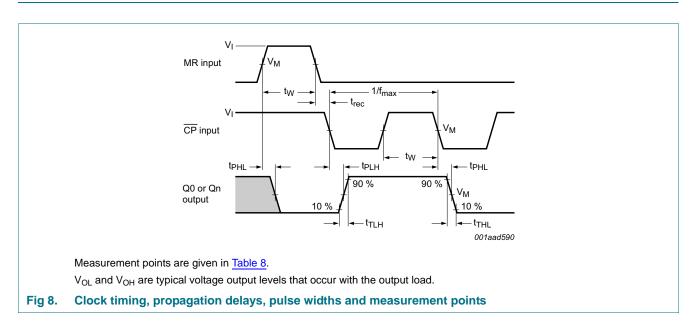
 $f_o = output frequency in MHz;$

 $\Sigma (C_L \times V_{CC}^2 \times f_o) =$ sum of outputs;

 C_L = output load capacitance in pF;

 V_{CC} = supply voltage in V.

12. Waveforms



14-stage binary ripple counter

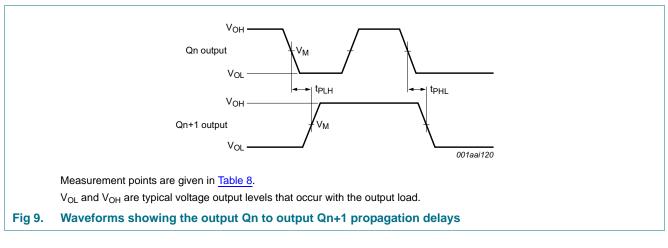


Table 8.Measurement points

Туре	Input	Output
	V _M	V _M
74HC4020	$0.5 \times V_{CC}$	$0.5 \times V_{CC}$
74HCT4020	1.3 V	1.3 V

14-stage binary ripple counter

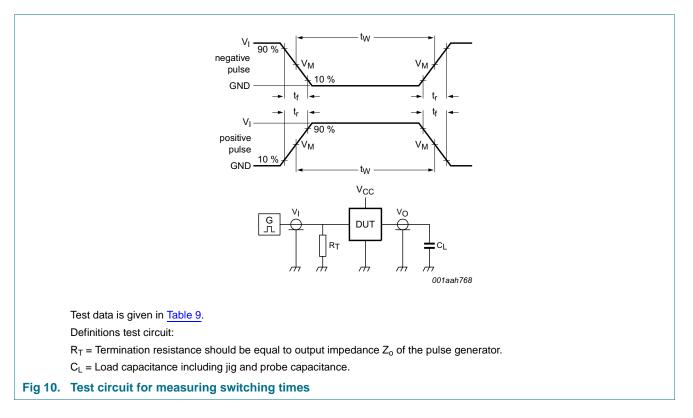


Table 9. Test data

Туре	Input	Load	
	VI	t _r , t _f	CL
74HC4020	V _{CC}	6 ns	15 pF, 50 pF
74HCT4020	3 V	6 ns	15 pF, 50 pF

14-stage binary ripple counter

13. Package outline

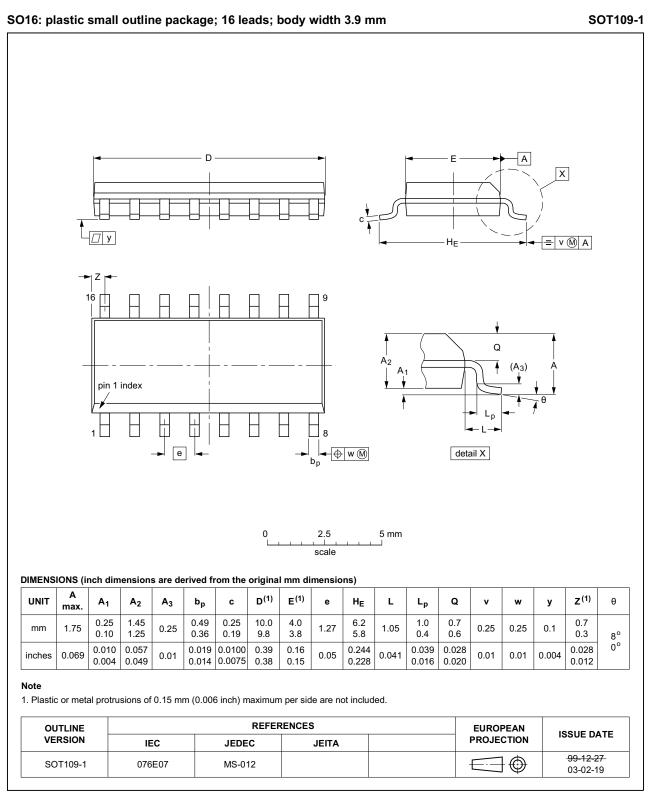


Fig 11. Package outline SOT109-1 (SO16)

14-stage binary ripple counter

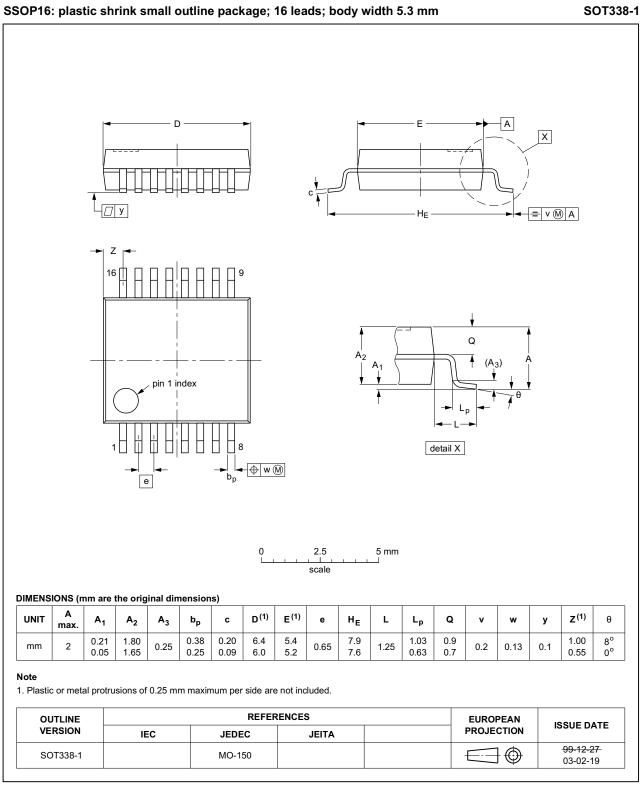


Fig 12. Package outline SOT338-1 (SSOP16)

14-stage binary ripple counter

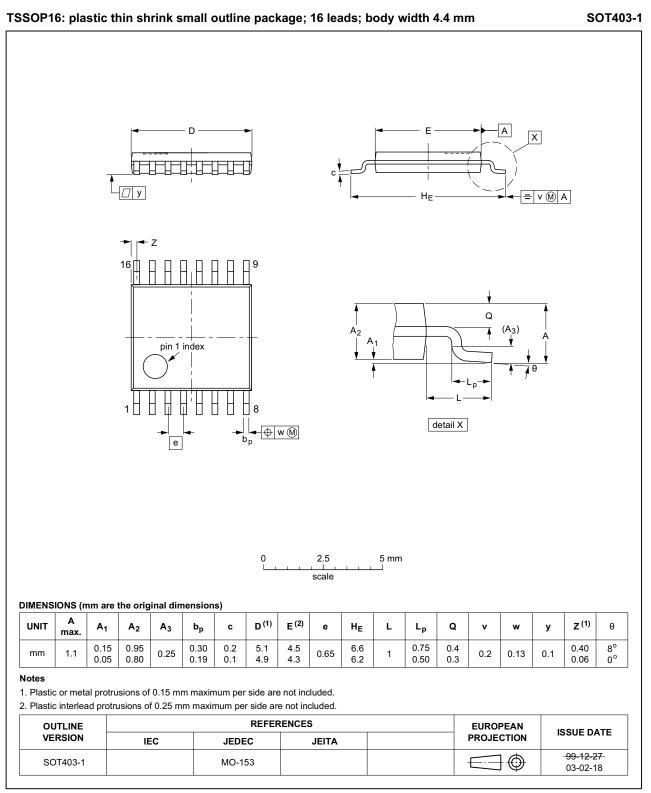
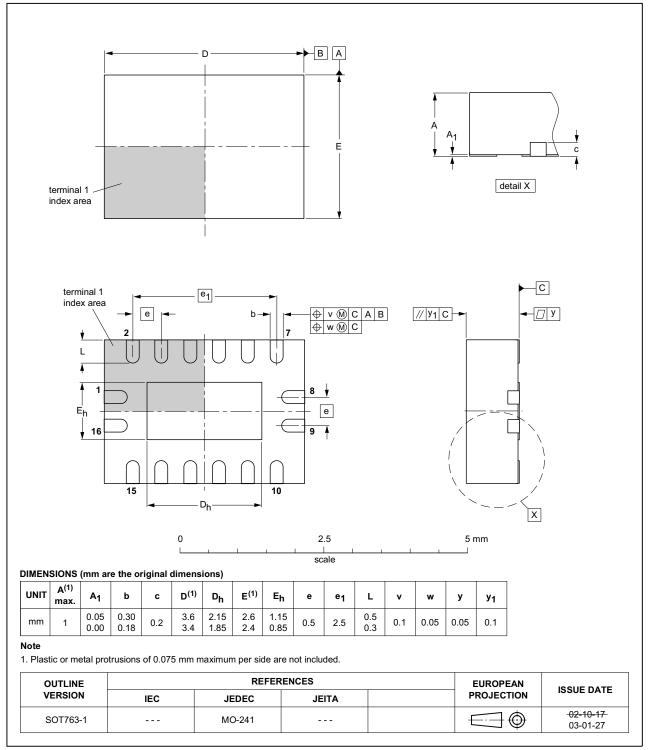


Fig 13. Package outline SOT403-1 (TSSOP16)

74HC_HCT4020

Product data sheet

14-stage binary ripple counter



DHVQFN16: plastic dual in-line compatible thermal enhanced very thin quad flat package; no leads; 16 terminals; body 2.5 x 3.5 x 0.85 mm SOT763-1

Fig 14. Package outline SOT763-1 (DHVQFN16)

14. Abbreviations

Table 10. Abbreviations	
Acronym	Abbreviation
CMOS	Complementary Metal Oxide Semiconductor
DUT	Device Under Test

15. Revision history

Table 11. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
74HC_HCT4020 v.6	20160203	Product data sheet	-	74HC_HCT4020 v.5
Modifications:	• Type numbers 74HC4020N and 74HCT4020N (SOT38-4) removed.			
74HC_HCT4020 v.5	20120806	Product data sheet	-	74HC_HCT4020 v.4
Modifications:	Measurement points added to figure 8 (errata).			
74HC_HCT4020 v.4	20111213	Product data sheet	-	74HC_HCT4020 v.3
Modifications:	Legal pages updated.			
74HC_HCT4020 v.3	20100120	Product data sheet	-	74HC_HCT4020_CNV v.2
74HC_HCT4020_CNV v.2	19970901	Product specification	-	-

16. Legal information

16.1 Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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18. Contents

1	General description 1
2	Features and benefits 1
3	Applications 1
4	Ordering information 1
5	Functional diagram 2
6	Pinning information 3
6.1	Pinning 3
6.2	Pin description 3
7	Functional description 4
7.1	Timing diagram 4
8	Limiting values 5
9	Recommended operating conditions 5
10	Static characteristics 6
11	Dynamic characteristics 7
12	Waveforms 9
13	Package outline 12
14	Abbreviations 16
15	Revision history 16
16	Legal information 17
16.1	Data sheet status 17
16.2	Definitions 17
16.3	Disclaimers
16.4	Trademarks 18
17	Contact information 18
18	Contents

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